



+1.8V, Low Power, 16-Bit Sigma-Delta A/D Converter

Features

- 16-bit Resolution at Eight Conversions Per Second, Adjustable Down to 10-bit Resolution at 512 Conversions Per Second
- 1.8V 5.5V Operation, Low Power Operating 260μA; Sleep: 0.75μA
- microPort[™] Serial Bus Requires only two Interface Lines
- Uses Internal or External Reference
- · Automatically Enters Sleep Mode when not in use

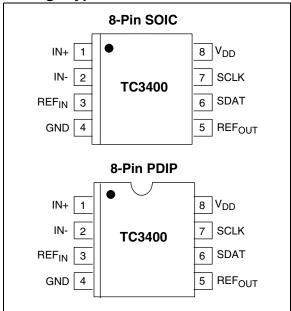
Applications

- Consumer Electronics, Thermostats, CO Monitors, Humidity Meters, Security Sensors
- Embedded Systems, Data Loggers, Portable Equipment
- · Medical Instruments

Device Selection Table

Part Number	Package	Temperature Range
TC3400VPA	8-Pin PDIP (Narrow)	0°C to +85°C
TC3400VOA	8-Pin SOIC (Narrow)	0°C to +85°C

Package Type



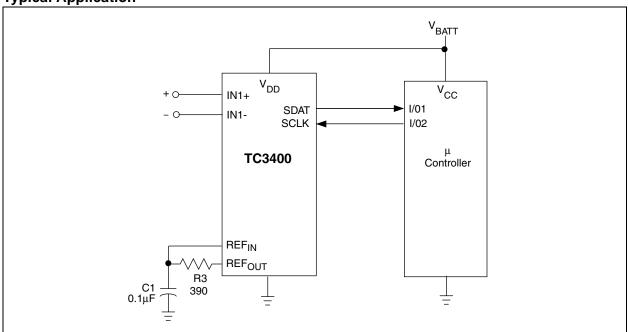
General Description

The TC3400 is a low cost, low power analog-to-digital converter based on Microchip's Sigma-Delta technology. It will perform 16-bit conversions (15-bit plus sign) at up to eight per second. The TC3400 is optimized for use as a microcontroller peripheral in low cost, battery operated systems. A voltage reference is included, or an external reference can be used.

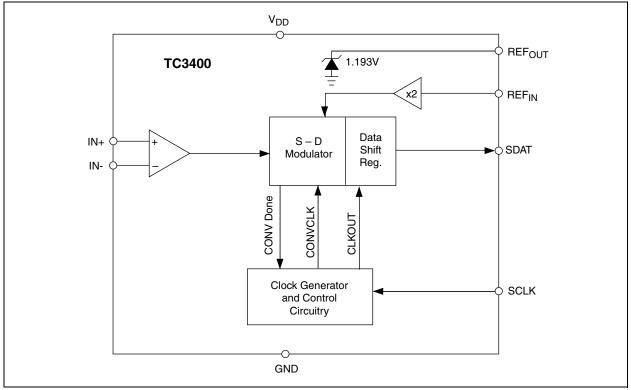
The TC3400's 2-wire microPortTM digital interface is used for starting conversions and for reading out the data. Driving the SCLK line low starts a conversion. After the conversion starts, each additional falling edge (up to six) detected on SCLK for t_4 seconds reduces the A/D resolution by one bit and cuts conversion time in half. After a conversion is completed, clocking the SCLK line puts the MSB through LSB of the resulting data word onto the SDAT line, much like a shift register. The part automatically sleeps when not performing a data conversion.

The TC3400 is available in a 8-Pin PDIP and a 8-Pin SOIC package.

Typical Application



Functional Block Diagram



1.0 ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings*

 *Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions above those indicated in the operation sections of the specifications is not implied. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability.

TC3400 DC ELECTRICAL SPECIFICATIONS

Electrical Characteristics: $T_A = 25^{\circ}C$ and $V_{DD} = 2.7V$, unless otherwise specified. Boldface type specifications apply for temperatures of $0^{\circ}C$ to $85^{\circ}C$. $V_{REF} = 1.25V$, Internal Clock Frequency = 520 kHz.								
Symbol	Parameter	Min	Тур	Max	Unit	Test Conditions		
Power Supply								
V_{DD}	Supply Voltage	1.8	_	5.5	V			
I _{DD}	Supply Current, During Data Conversion	_	260		μΑ			
I _{DDSLEEP}	Supply Current, Sleep Mode	_	0.75	1.5	μΑ	$T_A = +25$ °C		
		_	1.2	3.0	μΑ			
Accuracy (Differential Inputs)							
RES	Resolution	_	16	_	Bits			
INL	Integral Non-Linearity	_	.0038	_	%FSR	V _{DD} = 2.7V		
Vos	Offset Error	_	_	±0.9	%FSR	IN+, IN- = 0V		
V _{NOISE}	Referred to input	_	60	l	μVrms			
CMR	Common Mode Rejection	_	75		dB	At DC		
FSE	Full Scale Error	_	0.4%		%FS			
PSRR	R Power Supply Rejection Ratio		75	_	dB	$V_{DD} = 2.5V \text{ to } 3.5V$		
IN+, IN-								
V _{IN} ±	Differential Input Voltage		_	2.5	V	Note 1		
	Absolute Voltage Range on IN+, IN-	_	_	V_{DD}	V			
	Input Bias Current	_	1	100	nA			
C _{IN}	Input Sampling Capacitance		2	_	pF			
R _{IN}	Differential Input Resistance	_	2.0	_	$M\Omega$	Note 2		
REF _{IN,} REF	оит							
V_{REF}	REF _{IN} Voltage Range	0		1.25	V			
I _{REF}	REF _{IN} Input Current		1		μΑ			
V _{REFOUT}	REF _{OUT} Voltage		1.193		V			
REF _{SINK}	REF _{OUT} Current Sink Capability	_	10	_	μΑ			
REF _{SRC}	REF _{OUT} Current Source Capability	300	_	_	μΑ			

Note 1: Differential input voltage defined as $(V_{IN} + - V_{IN})$.

^{2:} Resistance from INn+ to INn- or INn to GND.

TC3400 DC ELECTRICAL SPECIFICATIONS (CONTINUED)

Electrical Characteristics: $T_A = 25^{\circ}C$ and $V_{DD} = 2.7V$, unless otherwise specified. Boldface type specifications apply for temperatures of $0^{\circ}C$ to $85^{\circ}C$. $V_{REF} = 1.25V$, Internal Clock Frequency = 520kHz .							
Symbol	Parameter	Min	Тур	Max	Unit	Test Conditions	
SCLK							
V _{IL}	Input Low Voltage	_	_	0.3 x V _{DD}	V		
V_{IH}	Input High Voltage	0.7 x V _{DD}	_	_	V		
I _{LEAK}	Leakage Current	_	1	_	μΑ		
SDAT							
V _{OL}	Output Low Voltage	_	_	0.4	V	I _{OL} = 1.5mA	
V _{OH}	Output High Voltage (SDAT)	0.9 x V _{DD}	_	_	V	I _{SOURCE} = 400μA (Note 3)	

- Note 1: Differential input voltage defined as $(V_{IN} + V_{IN})$.
 - 2: Resistance from INn+ to INn- or INn to GND.
 - 3: @ V_{DD} = 1.8V, $I_{SOURCE} \le 200 \mu A$.

TC3400 AC ELECTRICAL SPECIFICATIONS

Resolution Reduction Window

SCLK to Data Valid

Acknowledge Delay

Electrical Characteristics: $T_A = 25^{\circ}C$ and $V_{DD} = 2.7V$, unless otherwise specified. Boldface type specifications apply for temperatures of 0°C to 85°C. $V_{REF} = 1.25V$, Internal Clock Frequency = 520kHz. Symbol Min Unit **Test Conditions Parameter** Тур Max Resolution Reduction Clock Width 1 Width of SCLK (Negative) µsec Resolution Reduction Clock Width 1 Width of SCLK (Positive) µsec Conversion Time (15-bit Plus Sign) 125 16-bit Conversion, T_A = 25°C (Note 1) msec t_3 Conversion Time (14-bit Plus Sign) $t_3/2.0$ msec 15-bit Conversion Conversion Time (13-bit Plus Sign) $t_3/4.0$ msec 14-bit Conversion Conversion Time (12-bit Plus Sign) $t_3/7.8$ 13-bit Conversion msec Conversion Time (11-bit Plus Sign) $t_3/15.1$ msec 12-bit Conversion Conversion Time (10-bit Plus Sign) $t_3/28.6$ msec 11-bit Conversion Conversion Time (9-bit Plus Sign) $t_3/51.4$ msec 10-bit Conversion

 $t_3/85.7$

Note 1: Nominal temperature drift is -2830ppm/C° for temperature less than 25°C and -1340ppm/°C for temperatures greater than 25°C.

1000

 t_4

 t_5

t₈

Width of SCLK

SCLK to SDAT Delay

SCLK Falling Edge to SDAT Valid

msec

nsec

nsec

1000

2.0 PIN DESCRIPTIONS

The descriptions of the pins are listed in Table 2-1.

TABLE 2-1: PIN FUNCTION TABLE

Pin No. (8-Pin SOIC) (8-Pin PDIP)	Symbol	Description		
1	IN+	Analog Input. This is the positive terminal of a true differential input consisting of IN+ and IN $V_{IN1} = (IN+ - IN-)$. See Section 1.0 Electrical Characteristics.		
2	IN-	Analog Input. This is the negative terminal of a true differential input consisting of IN+ and IN $V_{IN} = (IN+-IN-)$ IN- can swing to, but not below, ground.		
3	REF _{IN}	Analog Input. The converter's reference voltage is the differential between this pin and ground times two. It may be tied directly to REF _{OUT} or scaled using a resistor divider. Any user supplied reference voltage less than 1.25V may be used in place of REF _{OUT} .		
4	GND	Ground Terminal.		
5	REF _{OUT}	Analog Output. The internal reference connects to this pin. It may be scaled externally, if desired, and tied to the REF _{IN} input to provide the converter's reference voltage. Care must be taken in connecting external circuitry to this pin.		
6	SDAT	Digital Output (push-pull). This is the microPort™ serial data output. SDAT is driven low while the TC3400 is converting data, effectively providing a "busy" signal. After the conversion is complete, every high to low transition on the SCLK pin puts a bit from the resulting data word on the SDAT pin (from MSB to LSB).		
7	SCLK	Digital Input. This is the microPort™ serial clock input. The TC3400 comes out of sleep mode and a conversion cycle begins when this pin is driven low. After the conversion starts, each additional falling edge (up to six) detected on SCLK for t₄ seconds reduces the A/D resolution by one bit. When the conversion is complete, the data word can be shifted out on the SDAT pin by clocking the SCLK pin.		
8	V_{DD}	Power Supply Input.		

3.0 DETAILED DESCRIPTION

The TC3400 is a 16-bit sigma-delta A/D converter with one differential input. See the Typical Application circuit and the Functional Block diagram. The key components of the TC3400 are described below.

Also refer to Figure 3-4, A/D Operational Flowchart and the Timing Diagrams, Figure 3-1, Figure 3-2 and Figure 3-3).

3.1 A/D Converter Operation

When the TC3400 is not converting, it is in sleep mode with both the SCLK and SDAT lines high. An A/D conversion is initiated by a high to low transition on the SCLK line at which time the internal clock of the TC3400 is started. Each additional high to low transition of SCLK (following the initial SCLK falling edge) during the time interval t_4 , will decrement the conversion resolution by one bit and reduce the conversion time by one half. The time interval t_4 is referred to as the resolution reduction window. The minimum conversion resolution is 10-bits so any more than 6 SCLK transitions during t_4 will be ignored.

After each high to low transition of SCLK, in the t_4 interval, the SDAT output is driven high by the TC3400 to acknowledge that the conversion has been decremented. When the SCLK returns high or the t_4 interval ends, the SDAT line returns low (see Figure 3-2). When the conversion is complete SDAT is driven high. The TC3400 now enters sleep mode and the conversion value can be read as a serial data word on the SDAT line.

3.2 Reading the Data Word

After the conversion is complete and SDAT goes high, the conversion value can be clocked serially onto the SDAT line by high to low transitions of the SCLK. The data word is in two's compliment format with the sign bit clocked onto the SDAT line, first followed by the MSB and ending in the LSB. For a 16-bit conversion the data word would consist of a sign bit followed by 15 magnitude bits, Table 3-1 shows the data word versus input voltage for a 16-bit conversion. Note that the full scale input voltage range is $\pm (2~{\rm REF_{IN}}-1{\rm LSB})$. When ${\rm REF_{OUT}}$ is fed back directly to ${\rm REF_{IN}}$, an LSB is $73\mu{\rm V}$ for a 16-bit conversion, as ${\rm REF_{OUT}}$ is typically 1.193V.

Figure 3-3 shows typical SCLK and SDAT waveforms for 16, 12 and 10-bit conversions. Note that any complete convert and read cycle requires 17 negative edge clock pulses. The first is the convert command. Then, up to six of these can occur in the resolution reduction window, t_4 , to decrement resolution. The remaining pulses clock out the conversion data word.

TABLE 3-1: DATA CONVERSION WORD VS. VOLTAGE INPUT (REF_{IN} = 1.193V)

Data Word	INn+ - INn- (Volts)
0111 1111 1111 1111	2.38596 (Positive Full Scale)
0000 0000 0000 0001	72.8 E -6
0000 0000 0000 0000	0
1111 1111 1111 1111	-72.8 E -6
1000 0000 0000 0001	-2.38596 (Negative Full Scale)
1000 0000 0000 0000	Reserved Code

The SCLK input has a filter which rejects any positive or negative pulse of width less than 50nsec to reduce noise. The rejection width of this pulse can vary between 50nsec and 750nsec depending on processing parameters and supply voltage.

Figure 3-1 and Table 3-2 show information for determining the mode of operation for the TC3400 part by recording the value of SDAT for SCLK in a high, then low, then high state. For example, if SCLK goes through a 1-0-1 transition and the corresponding values of SDAT are 1-1-0, then the SCLK falling edge started a new data conversion. A 0-1-0 for SDAT would have indicated a resolution reduction had occurred. This is useful if the microcontroller has a watchdog reset or otherwise loses track of where the TC3400 is in the conversion and data readout sequence. The microcontroller can simply transition SCLK until it "finds" a Start Conversion condition.

FIGURE 3-1: SCLK, SDAT LOGIC STATE DIAGRAM

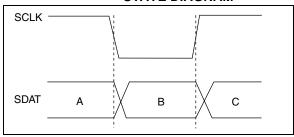


TABLE 3-2: SCLK, SDAT LOGIC STATE

Α	В	С	Status		
1	1	0	Start Conversion		
0	1	0	Resolution Reduction		
Х	1	1	Data Transfer		
Х	0	0	Data Transfer or Busy*		

*Note: The code X00 has a dual meaning: Data Transfer or Busy converting. To avoid confusion, the user should send only the required number of pulses for the desired resolution, then wait for SDAT to rise to 1, indicating conversion is complete before clocking SCLK again to read out data bits.



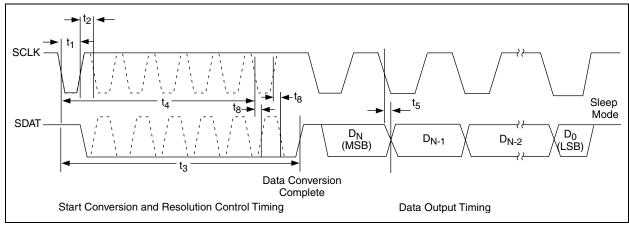
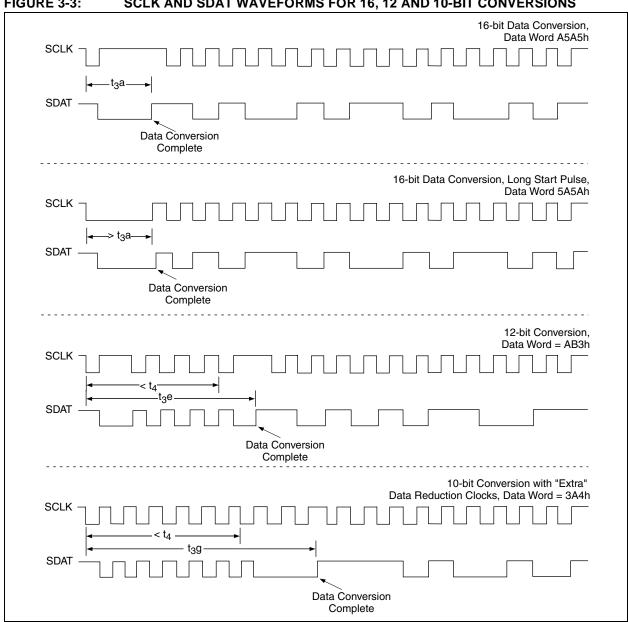
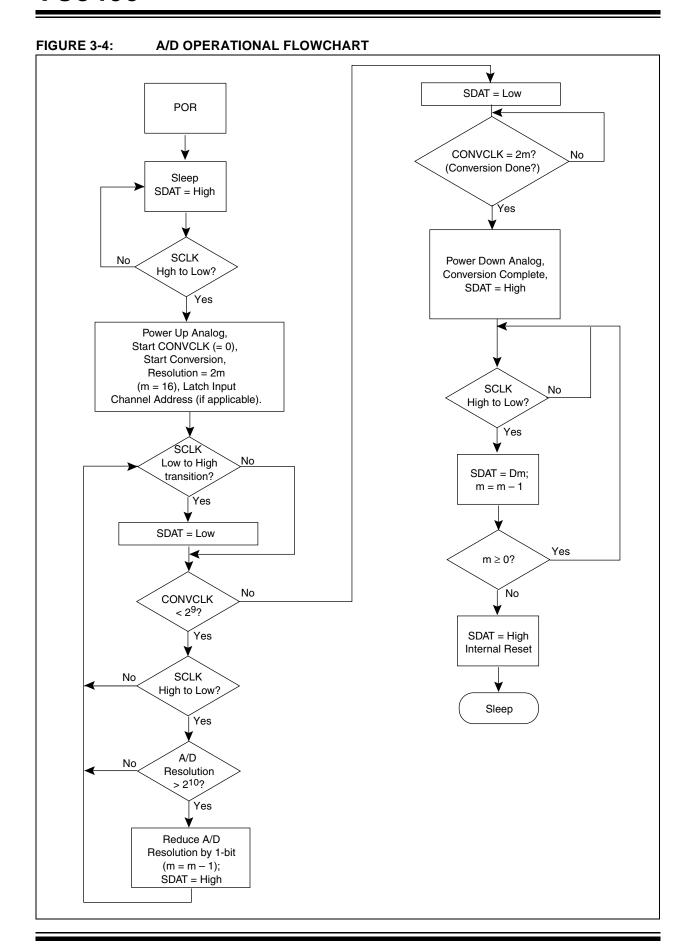


FIGURE 3-3: SCLK AND SDAT WAVEFORMS FOR 16, 12 AND 10-BIT CONVERSIONS





4.0 PACKAGING INFORMATION

4.1 Package Marking Information

Package marking data not available at this time.

4.2 Taping Forms

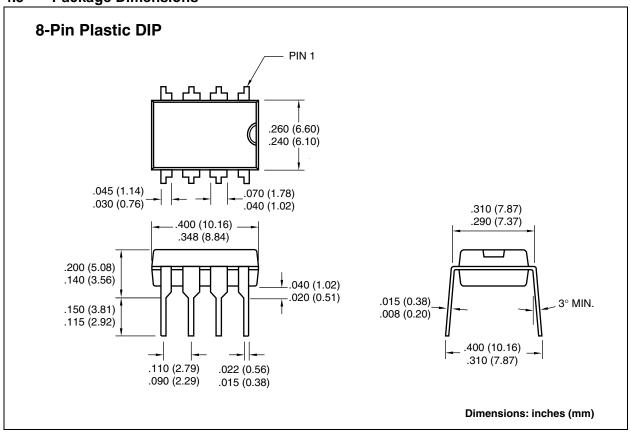
Component Taping Orientation for 8-Pin SOIC (Narrow) Devices User Direction of Feed W PIN 1 P P

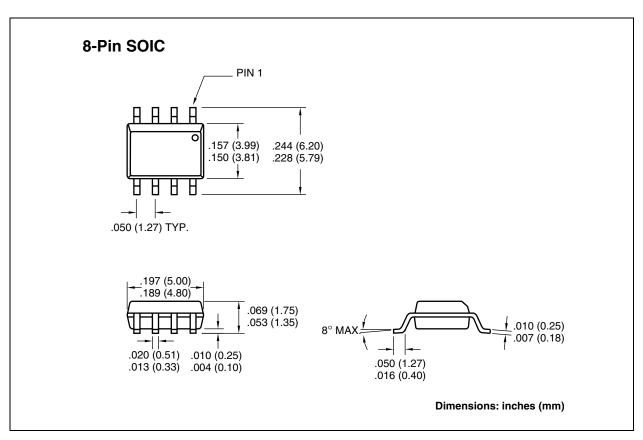
Standard Reel Component Orientation for TR Suffix Device

Carrier Tape, Number of Components Per Reel and Reel Size

Package	Carrier Width (W)	Pitch (P)	Part Per Full Reel	Reel Size
8-Pin SOIC (N)	12 mm	8 mm	2500	13 in

4.3 Package Dimensions





NOTES:

TC3400

NOTES:

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TC3400

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